

# MOSFET - Power, Single N-Channel 100 V, 10.6 mΩ, 57.8 A

## **NVTFS010N10MCL**

#### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS010N10MCLTAG Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	100	V
Gate-to-Source Voltage	€		$V_{GS}$	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	57.8	Α
Current R <sub>0JC</sub> (Notes 1, 2, 3)	Steady	T <sub>C</sub> = 100°C		40.8	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	77.8	W
R <sub>θJC</sub> (Notes 1, 2)		T <sub>C</sub> = 100°C		38.9	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	11.7	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady State	T <sub>A</sub> = 100°C		8.3	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.2	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	T <sub>C</sub> = 25	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	232	Α
Source Current			Is	64.8	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 2.9 A)			E <sub>AS</sub>	526	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

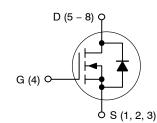
#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

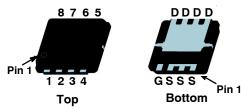
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	1.93	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	46.6	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
100 V	10.6 m $\Omega$ @ 10 V	57.8 A	
	15.9 mΩ @ 4.5 V	37.6 A	

#### N-Channel





WDFN8 (3.3x3.3, 0.65 P) CASE 511DY



WDFNW8 (Full-Cut μ8FL Fused WF) CASE 515AP

#### **MARKING DIAGRAM**



N10x = Specific Device Code

x = L or W

A = Assembly Location
Y = Year Code
WW = Work Week Code

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				64		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	_ = 85 μΑ	1.0	1.5	3.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 15 A		9.1	10.6	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 12 A		13.5	15.9	
Forward Transconductance	9FS	V <sub>DS</sub> =5 V, I <sub>D</sub> = 15 A			54		S
CHARGES AND CAPACITANCES						•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			1530	2150	pF
Output Capacitance	C <sub>OSS</sub>				625	875	
Reverse Transfer Capacitance	C <sub>RSS</sub>				10	18	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 15 A			10		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 15 A			22	30	nC
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V; I <sub>D</sub> = 15 A			4.0		nC
Gate-to-Drain Charge	$Q_{GD}$				3.0		
SWITCHING CHARACTERISTICS (Note 5	)						
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0		
Rise Time	t <sub>r</sub>	VGS = 10 V. Vr	ng = 50 V.		3.0		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 50 V, $I_{D}$ = 15 A, $R_{G}$ = 6 $\Omega$			28		ns
Fall Time	t <sub>f</sub>				5.0		
DRAIN-SOURCE DIODE CHARACTERIS	TICS					•	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 15 A			0.8	1.3	V
Reverse Recovery Time	t <sub>RR</sub>	I <sub>F</sub> = 8 A, di/dt = 300 A/μs			22	36	ns
Reverse Recovery Charge	Q <sub>RR</sub>				35	56	nC
Reverse Recovery Time	t <sub>RR</sub>	I <sub>F</sub> = 8 A, di/dt = 1000 A/μs			17	30	ns
Reverse Recovery Charge	Q <sub>RR</sub>				79	126	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

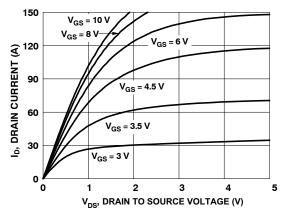


Figure 1. On Region Characteristics

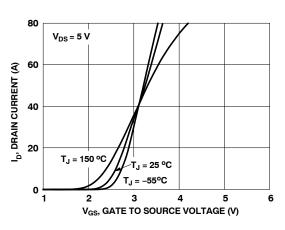


Figure 2. Transfer Characteristics

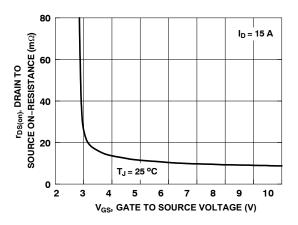


Figure 3. On-Resistance vs. Gate to Source Voltage

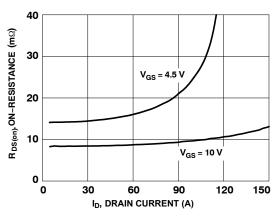


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

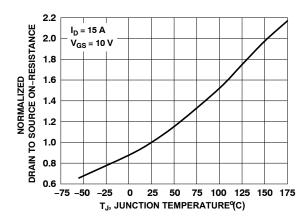


Figure 5. Normalized On Resistance vs. Junction Temperature

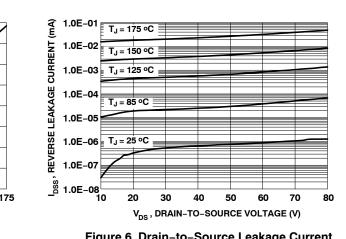


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

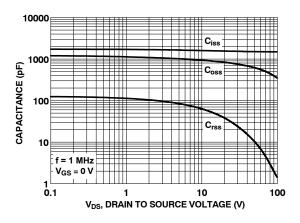


Figure 7. Capacitance vs. Drain to Source Voltage

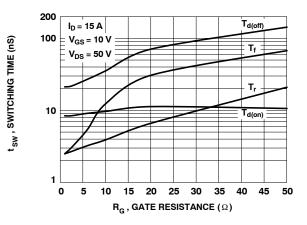


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

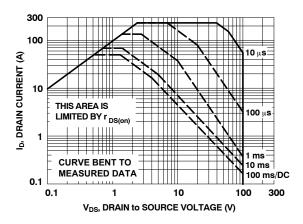


Figure 11. Forward Bias Safe Operating Area

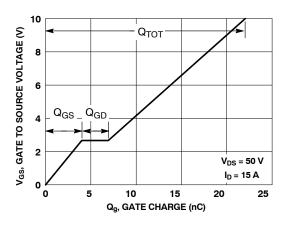


Figure 8. Gate Charge Characteristics

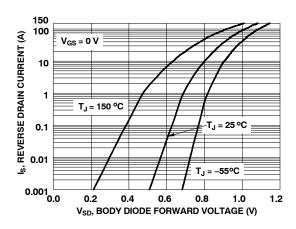


Figure 10. Source to Drain Diode Forward Voltage vs. Source Current

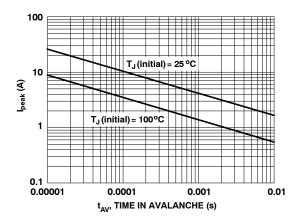


Figure 12. Unclamped Inductive Switching Capability

### TYPICAL CHARACTERISTICS (CONTINUED)

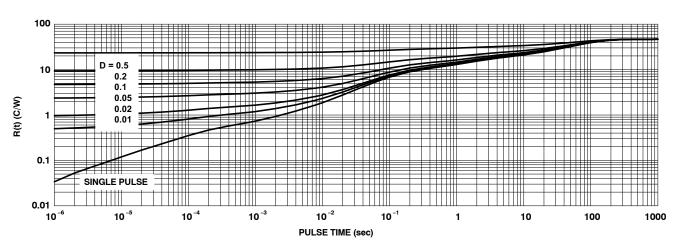


Figure 13. Junction-to-Case Transient Thermal Response Curve

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS010N10MCLTAG	N10L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS010N10MCLTAG	N10W	WDFNW8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### WDFN8 3.3x3.3, 0.65P CASE 511DY **ISSUE A**

**DATE 21 AUG 2018** 

MILLIMETERS

0.75

0.33

0.20

3.30

3.13 2.20

3.30

3.00

1.60

0.25

0.65 BSC

0.43

0.35

0.75

0.52

0.15

1.50

NOM MAX

0.80

0.05

0.43

0.25

3.40

3.30

2.40

3.40

3.15

1.80

0.40

0.55

0.45

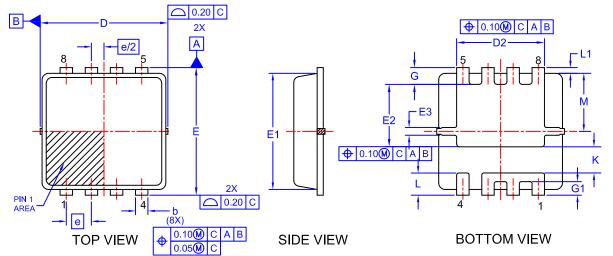
0.95

0.65

0.30

1.60

12



#### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETERS
- 2. DIMENSIONS D1 & E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS NOR GATE BURRS.

DIM

Α

**A**1

b

С

D

D1

D2

Е

E1

E2

E3

е G

G1

Κ

L

L1

М

θ

MIN

0.70

0.00

0.23

0.15

3.20

2.95

1.98

3.20

2.80

1.40

0.15

0.30

0.25

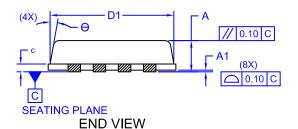
0.55

0.35

0.06

1.35

0



3.46 0.78 (4X) 0.75 2.51 0.57 1.00 0.60 (3X) -0.43 (8X) RECOMMENDED LAND PATTERN

#### **GENERIC MARKING DIAGRAM\***

XXXX AYWW

XXXX = Specific Device Code = Assembly Location = Year Code

WW = Work Week Code

*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot " ■",
may or may not be present. Some products
may not follow the Generic Marking.

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ALL DIMENSION ARE IN MILLIMETERS.

PROTRUSIONS, OR GATE BURRS.



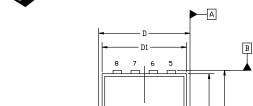
#### WDFNW8 3.30x3.30x0.75, 0.65P

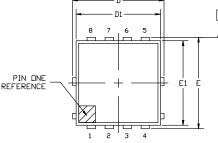
CASE 515AP **ISSUE A** 

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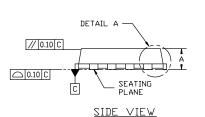
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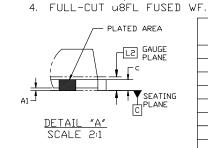
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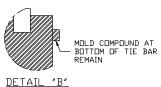




TOP VIEW

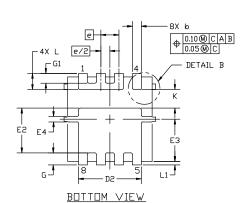


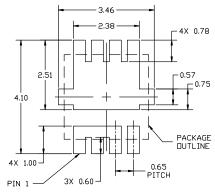




SCALE 2:1

MILLIMETERS DIM MIN. NDM. MAX. 0.70 0.75 0.80 Α A1 0.00 0.05 b 0.23 0.33 0.43 0.15 0.20 0.25 C П 3.20 3.30 3.40 D1 2.95 3.13 3.30 1.98 D2 2.20 2.40 Ε 3.20 3.30 3.40 2.80 3.00 E1 3.15 1.40 1.60 1.80 E2 F3 1.35 1.50 1.60 E4 0.15 0.25 0.40 0.65 BSC e G 0.30 0.43 0.55 0.25 G1 0.35 0.45 0.55 Κ 0.75 0.95 0.35 0.52 0.65 1 L1 0.06 0.15 0.30 0.25 BSC L2





#### RECOMMENDED MOUNTING FOOTPRINT\*

FOR ADDITIONAL INFORMATION ON OUR Pb-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD
THE ON SEMICONDUCTOR SOLDERING AND MOUNTING
TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### **GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code

= Assembly Location

= Year

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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